

PROCEEDINGS OF SPIE

# ***Passive Millimeter-Wave Imaging Technology XIII***

**David A. Wikner  
Arttu R. Luukanen**  
*Editors*

**8 April 2010  
Orlando, Florida, United States**

*Sponsored and Published by*  
SPIE

**Volume 7670**

Proceedings of SPIE, 0277-786X, v. 7670

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Author(s), "Title of Paper," in *Passive Millimeter-Wave Imaging Technology XIII*, edited by David A. Wikner, Arttu R. Luukanen, Proceedings of SPIE Vol. 7670 (SPIE, Bellingham, WA, 2010) Article CID Number.

ISSN 0277-786X  
ISBN 9780819481344

Published by

**SPIE**

P.O. Box 10, Bellingham, Washington 98227-0010 USA  
Telephone +1 360 676 3290 (Pacific Time) · Fax +1 360 647 1445  
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